


<b>Search Notes</b>  	<b>Application/Control No.</b>  10803940	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEYAMA ET AL.
	<b>Examiner</b>  KENDRICK X LIU	<b>Art Unit</b>  4193

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted primary examiner Hai Pham (claims 3-19 and 22-38 allowable)	3/17-4/12/08	KxL
Limited classification search (399/223, 299, 301, 302; 347/115, 116), see search history	3/10-4/30/08	KxL
Text search, see search history	3/10-4/30/08	KxL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner